

TEST REPORT						
FCC ID:	2AAPK-MA-3675B					
Test Report No::	TCT230717E007					
Date of issue::	Jul. 20, 2023					
Testing laboratory:	SHENZHEN TONGCE TESTING	LAB				
Testing location/ address:		2101 & 2201, Zhenchang Factory Renshan Industrial Zone, Fuhai Subdistrict, Bao'an District, Shenzhen, Guangdong, 518103, People's Republic of China				
Applicant's name::	Shenzhen Kingsun Enterprises C	Co., Ltd.				
Address::	25/F, CEC Information Building, 2 Guangdong 518034 China	Xinwen Rd., Shenzhen,				
Manufacturer's name:	Shenzhen Kingsun Enterprises C	Co., Ltd.				
Address::	25/F, CEC Information Building, Xinwen Rd., Shenzhen, Guangdong 518034 China					
Standard(s)::	KDB 447498 D01 General RF Exposure Guidance v06					
Product Name::	Prodigy Pro TWS Earphones with Charging Case					
Trade Mark:	N/A					
Model/Type reference:	MA-3675-B, AI1009, AI1009-BLK, AI1009-WHT					
Rating(s)::	Rechargeable Li-ion Battery DC	3.7V				
Date of receipt of test item:	Jul. 17, 2023	(C <sup>(</sup> )	(C)			
Date (s) of performance of test:	Jul. 17, 2023 - Jul. 20, 2023					
Tested by (+signature):	Ronaldo LUO	Paraleta Chage				
Check by (+signature):	Beryl ZHAO	BoyC TOT				
Approved by (+signature):	Tomsin	Tomsies &				

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## 1. General Product Information

## 1.1. EUT description

Product Name:	Prodigy Pro TWS Earphones with Charging Case	(,c')	
Model/Type reference:	MA-3675-B		
Sample Number:	TCT230717E006-0101		
Operation Frequency:	2402MHz~2480MHz		
Modulation Type:	GFSK, π/4-DQPSK, 8DPSK		
Antenna Type:	Chip Antenna		
Antenna Gain:	2.67dBi		
Rating(s):	Rechargeable Li-ion Battery DC 3.7V		

Note: The antenna gain listed in this report is provided by applicant, and the test laboratory is not responsible for this parameter.

# 1.2. Model(s) list

No.	Model No.	Tested with
1	MA-3675-B	
Other models	AI1009, AI1009-BLK, AI1009-WHT	

Note: MA-3675-B is tested model, other models are derivative models. The models are identical in circuit and PCB layout, different on the model names. So the test data of MA-3675-B can represent the remaining models.





## 2. General Information

### 2.1. Test environment and mode

Item	Normal condition						
Temperature	+25°C						
Voltage	DC 3.7V						
Humidity	56%						
Atmospheric Pressure:	1008 mbar						
Test Mode:							
Transmitting mode:	Keep the EUT in continuous transmitting by select channel						

## 2.2. Description of Support Units

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

Equipment Model No.		Serial No.	FCC ID	Trade Name	
1			1	1	

#### Note:

- 1. All the equipment/cables were placed in the worst-case configuration to maximize the emission during the test.
- 2. Grounding was established in accordance with the manufacturer's requirements and conditions for the intended use.
- 3. For conducted measurements (Output Power, 20dB Occupied Bandwidth, Carrier Frequencies Separation, Hopping Channel Number, Dwell Time, Spurious Emissions), the antenna of EUT is connected to the test equipment via temporary antenna connector, the antenna connector is soldered on the antenna port of EUT, and the temporary antenna connector is listed in the Test Instruments.



## 3. Facilities and Accreditations

#### 3.1. Facilities

The test facility is recognized, certified, or accredited by the following organizations:

• FCC - Registration No.: 645098

SHENZHEN TONGCE TESTING LAB

**Designation Number: CN1205** 

The testing lab has been registered and fully described in a report with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files.

IC - Registration No.: 10668A-1

SHENZHEN TONGCE TESTING LAB

CAB identifier: CN0031

The testing lab has been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing.

#### 3.2. Location

SHENZHEN TONGCE TESTING LAB

Address: 2101 & 2201, Zhenchang Factory, Renshan Industrial Zone, Fuhai Subdistrict, Bao'an District, Shenzhen, Guangdong, 518103, People's Republic of China

TEL: +86-755-27673339





## 4. Test Results and Measurement Data

According to KDB 447498 D01 General RF Exposure Guidance v06, systems operating under the provisions of this section shall be operated in a manner that ensures that the public is not exposed to radio frequency energy level in excess of the commission's guidance.

The 1-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances ≤ 50 mm are determined by:

[(max. power of channel, including tune-up tolerance, mW) / (min. test separation distance, mm)]  $\cdot [\sqrt{f(GHz)}] \le 3.0$  for 1-g SAR, where

- f(GHz) is the RF channel transmit frequency in GHz
- · Power and distance are rounded to the nearest mW and mm before calculation
- When the minimum test separation distance is < 5 mm, a distance of 5 mm according is applied to determine SAR test exclusion.
- The result is rounded to one decimal place for comparison

#### BDR+EDR:

Channel	Frequency (GHz)	Max. Power (dBm)	Tune up Power (dBm)	Max. Tune up Power (dBm)	Max. Tune up Power (mW)	Test distance (mm)	Result	exclusion thresholds for 1-g SAR
CH 0	2.402	3.22	3±1	4	2.51	5	0.78	3.0

#### Result:

Base on the calculation value, No SAR measurement is required.

\*\*\*\*\*END OF REPORT\*\*\*\*

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